

Search Notes



Application/Control No.

10/650,173

Examiner

Sang Y. Paik

Applicant(s)/Patent under Reexamination

HE ET AL.

Art Unit

3742

SEARCHED

Class	Subclass	Date	Examiner
392	386-406		
239	34-16		
	135		
	136	9/26/07	SP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST GER KARUNGO	9/26/07	Y